

**Search Notes**

Application/Control No.

09/956,911

Examiner

Cheukfan Lee

Applicant(s)/Patent under  
Reexamination

TAKAHASHI, HIROSHI

Art Unit

2627

**SEARCHED**

Class	Subclass	Date	Examiner
358	474,497, 1.17,1.16	10/21/2005	C.L.
	404,444		
	451		
	449		
399	362		
355	25		
382	318		
	319		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
358	404,444	10/26/2005	C.L.
	449,451		
	497		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search: terms include: ((book (bound adj (document original))) with (scan\$5 read\$3)) same ((size dimension) near5	10/21/2005	C.L.
search terms (cont.): (vary\$3 varie\$2 chang\$3)) same (memory buffer RAM)		